

New Product

N-Channel Reduced Q_g, Fast Switching WFET®

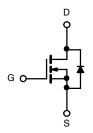
PRODUCT SUMMARY				
V _{DS} (V)	$r_{DS(on)}\left(\Omega\right)$	I _D (A)		
30	0.0032 at V _{GS} = 10 V	25		
	0.0036 at V _{GS} = 4.5 V	22		

FEATURES

- Extremely Low Q_{gd} WFET Technology for Switching Losses Improvement
- TrenchFET® Gen II Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- Low-Side DC/DC Conversion
 - Notebook, Server, VRM Module
- Fixed Telecom



N-Channel MOSFET

		SO-8		
s	1		8	D
	\vdash		0	
S	2		7	D
S	3		6	D
G	4		5	D
	,	Top View	•	

Ordering Information: Si4368DY-T1-E3 (Lead (Pb)-free)

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unle	ess otherwise	noted		
Parameter		Symbol	10 sec	Steady State	Unit
Drain-Source Voltage		V _{DS}	30		V
Gate-Source Voltage		V _{GS}	± 12		V
Continuous Drain Current /T 150 °C\a	T _A = 25 °C	- I _D	25	17	
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 70 °C		20	13	
Pulsed Drain Current (10 µs Pulse Width)		I _{DM}	70		Α
Continuous Source Current (Diode Conduction) ^a		I _S	2.9	1.3	
Avalanch Current	L = 0.1 mH	I _{AS}	50		
Mariana Barra Birainatian	T _A = 25 °C	В	3.5	1.6	W
Maximum Power Dissipation ^a	T _A = 70 °C	P _D	2.2	1	VV
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Mariana baratian ta Andrianta	t ≤ 10 sec	R _{thJA}	29	35		
Maximum Junction-to-Ambient ^a	Steady State		67	80	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State		13	16		

Notes:

a. Surface Mounted on 1" x 1" FR4 Board.

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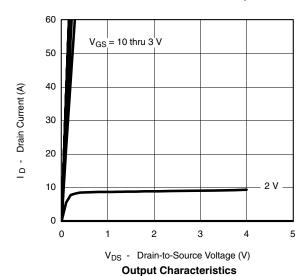
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
Static							
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6		1.8	V	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 12 V		± 100	nA		
7 0		V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance ^a		V _{GS} = 10 V, I _D = 25 A		0.0026	0.0032	Ω	
	r _{DS(on)}	V _{GS} = 4.5 V, I _D = 22 A		0.0029	0.0036		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 25 A		150		S	
Diode Forward Voltage ^a	V _{SD}	I _S = 2.9 A, V _{GS} = 0 V		0.66	1.1	V	
Dynamic ^b				•			
Input Capacitance	C _{iss}			8340		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		850			
Reverse Transfer Capacitance	C _{rss}			355			
Total Gate Charge	Q_g			53	80		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		17.5		nC	
Gate-Drain Charge	Q_{gd}			6.5			
Gate Resistance	R_g	f = 1 MHz	0.8	1.2	1.8	Ω	
Turn-On Delay Time	t _{d(on)}			25	38		
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		20	30		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1 A, V_{GEN} = 10 V, R_g = 6 Ω		172	260	ns	
Fall Time	t _f			41	62		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = 2.9 A, di/dt = 100 A/μs		42	60		

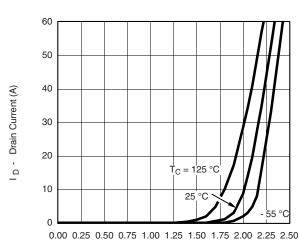
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V_{GS} - Gate-to-Source Voltage (V)

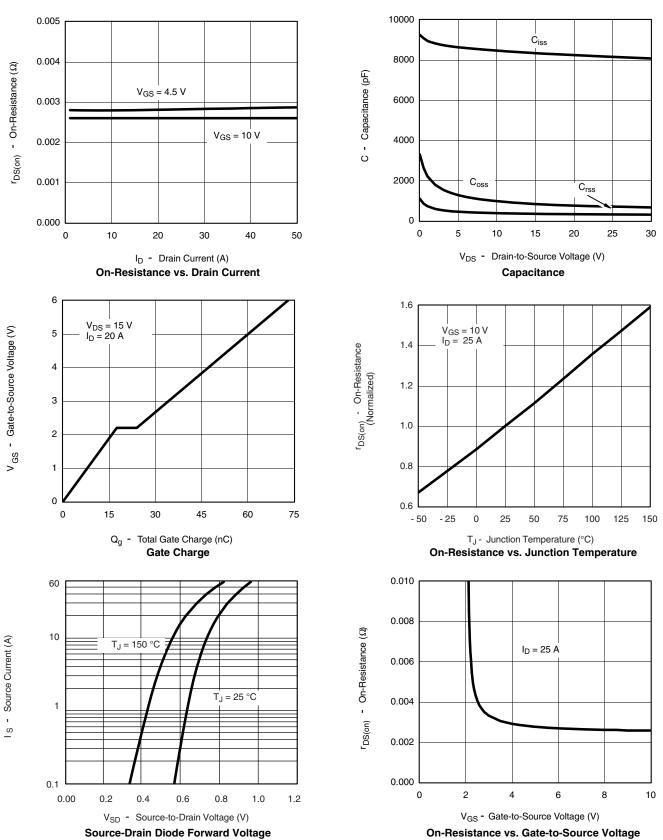
Transfer Characteristics







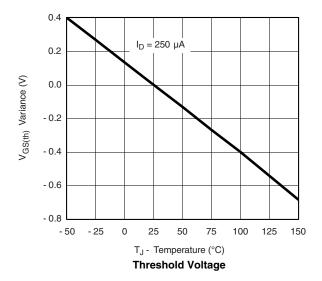
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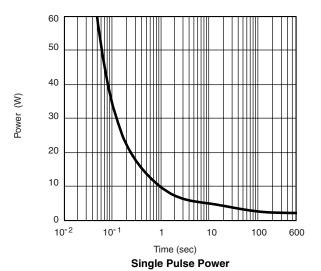


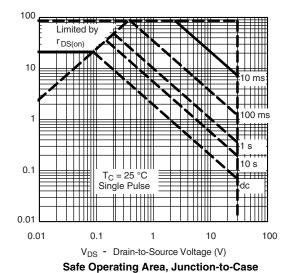
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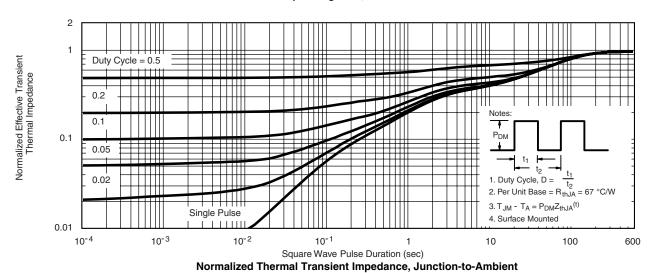
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



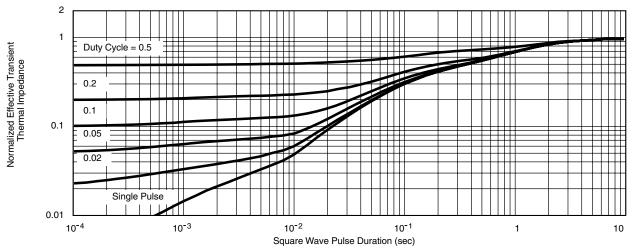








TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?72704.



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